

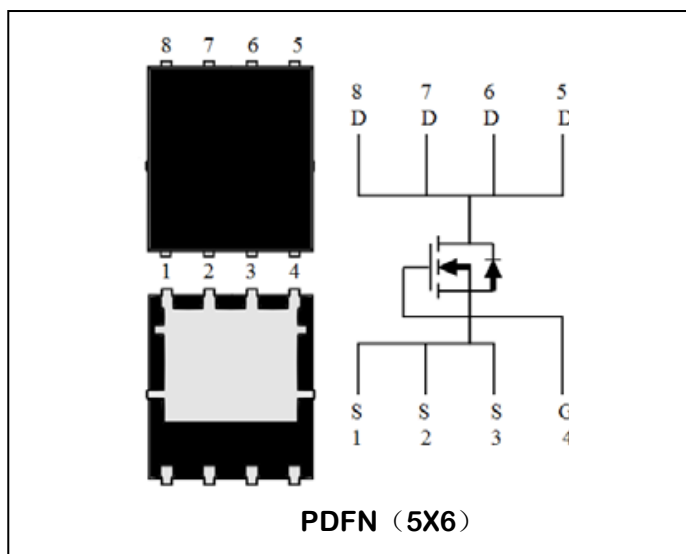
N-Channel Enhancement Mode Field Effect Transistor

PRODUCT SUMMARY

V_{DSS}	I_D	$R_{DS(ON)}$ (m Ω)
30V	92A	1.9m Ω

Features:

- Low Gate Charge for Fast Switching Application
- Low $R_{DS(ON)}$ to Minimize Conductive Loss
- 100% EAS Guaranteed
- Optimized $V_{(BR)DSS}$ Ruggedness
- Lead-Free,RoHS Compliant



Description:

The ADM92N03 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter		Ratings	Unit
Common Ratings				
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		±20	
T _J	Maximum Junction Temperature		150	°C
T _{STG}	Storage Temperature Range		-55 to150	°C
I _S	Diode Continuous Forward Current	T _C =25°C	92	A
Mounted on Large Heat Sink				
I _{DM}	300μs Pulse Drain Current Tested ⁽²⁾	T _C =25°C, V _{GS} =10V	191	A
I _D	Continuous Drain Current ⁽¹⁾	T _C =25°C, V _{GS} =10V	151	A
		T _C =100°C V _{GS} =10V	92	A
P _D	Maximum Power Dissipation	T _C =25°C	78	W

Thermal Characteristics

Symbol	Parameter	Ratings	Unit
R_{thJC}	Thermal resistance junction-case max ⁽¹⁾	1.6	$^\circ\text{C/W}$
R_{thJA}	Thermal resistance junction-ambient max ⁽¹⁾	50	$^\circ\text{C/W}$

Electrical Characteristics (TA=25°C Unless Otherwise Noted)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
On/off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =1mA	30	--	--	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24V, V _{GS} =0V	--	--	1	uA
		V _{DS} =24V, V _{GS} =0V T _J =125°C	--	--	100	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250uA	1.2	--	2.5	V
I _{GSS}	Gate Leakage Current	V _{GS} =± 20V, V _{DS} =0V	--	--	± 100	nA
R _{DS(ON)}	Drain-SourceOn-stateResistance(2)	V _{GS} = 10V, I _{DS} =32A	--	1.4	1.9	mΩ
		V _{GS} = 4.5V, I _{DS} =32A	--	1.8	2.4	
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} = 15V, Frequency=1.0MHz	--	2580	--	pF
C _{oss}	Output Capacitance		--	740	--	
C _{rss}	Reverse Transfer Capacitance		--	210	--	
Switching Characteristics						
t _{d(ON)}	Turn-on Delay Time(1)	V _{DD} =15V, I _D = 16A, V _{GS} = 10V, R _{GEN} =10 Ω R _L =0.94 Ω	--	21.8	--	ns
t _r	Turn-on Rise Time(1)		--	15.6	--	
t _{d(OFF)}	Turn-off Delay Time(1)		--	74.6	--	
t _f	Turn-off Fall Time(1)		--	28.5	--	
Q _g	Total Gate Charge(1)	V _{DS} =15V, V _{GS} = 4.5V, I _{DS} =32A	--	19.6	--	nC
Q _{gs}	Gate-Source Charge(1)		--	11.6	--	
Q _{gd}	Gate-Drain Charge(1)		--	6.7	--	
Avalanche Characteristics						
EAS	Single Pulse Avalanche Energy ⁽³⁾	V _{DD} =15V, L=0.1mH ,V _{GS} =10 V, R _g =25 Ω	102	--	--	mJ
Diode Characteristics						
V _{SD}	Diode Forward Voltage(2)	I _{SD} = 32A, V _{GS} = 0	--	--	1.2	V
t _{rr}	Reverse Recovery Time	I _{SD} =32A, dI _{SD} /dt=100A/μs	--	37.8	--	ns
q _{rr}	Reverse Recovery Charge		--	35.2	--	nC

NOTES:

1. Surface Mounted on FR4 Board, t ≤ 10 sec.
2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%
3. The Min. value is 100% EAS tested guarantee.

Typical Performance Characteristics

Figure 1: On-Region Characteristics

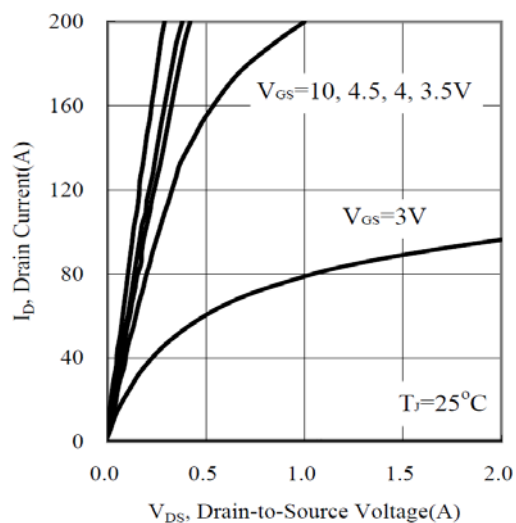


Figure 2: Power Dissipation

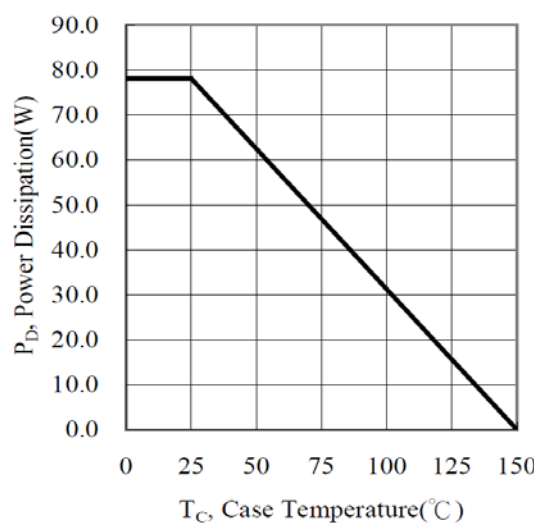


Figure 3: Drain Current

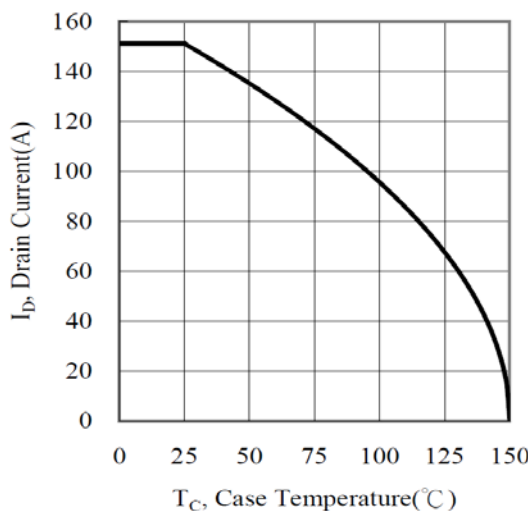


Figure 4: Drain-to-Source Breakdown Voltage

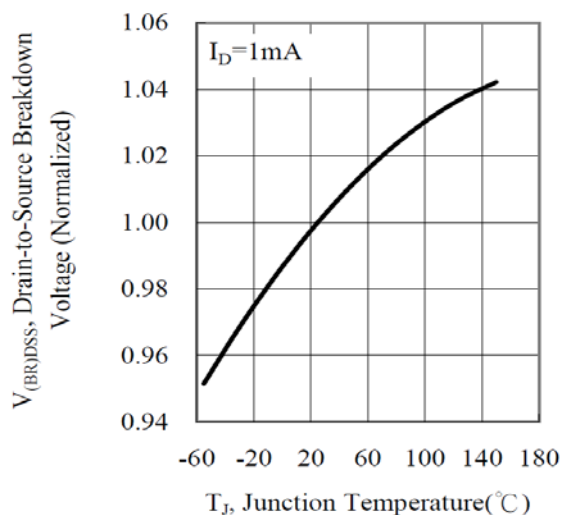


Figure 5: Capacitance Characteristics

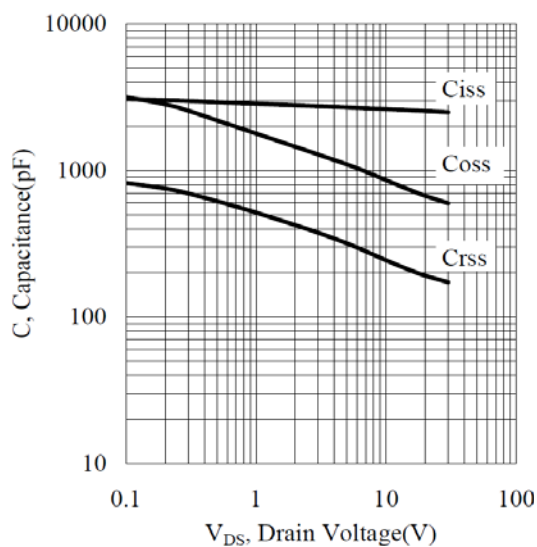


Figure 6: Gate Charge Characteristics

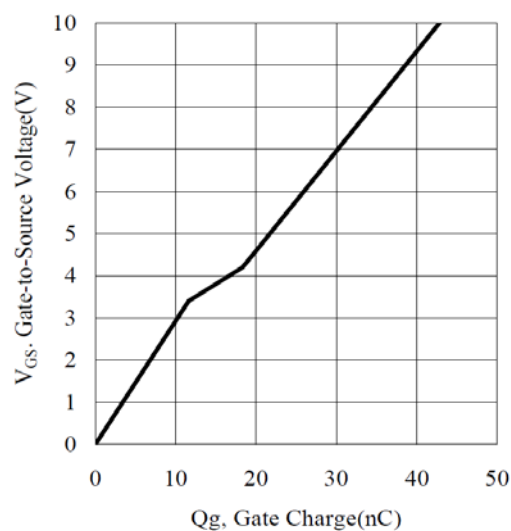


Figure 7: Gate Threshold Voltage

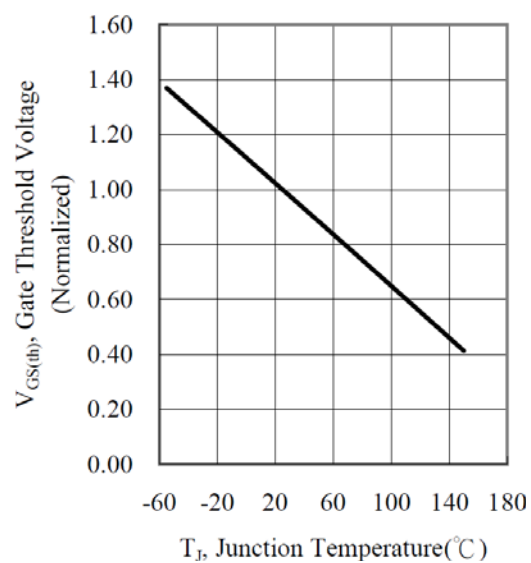
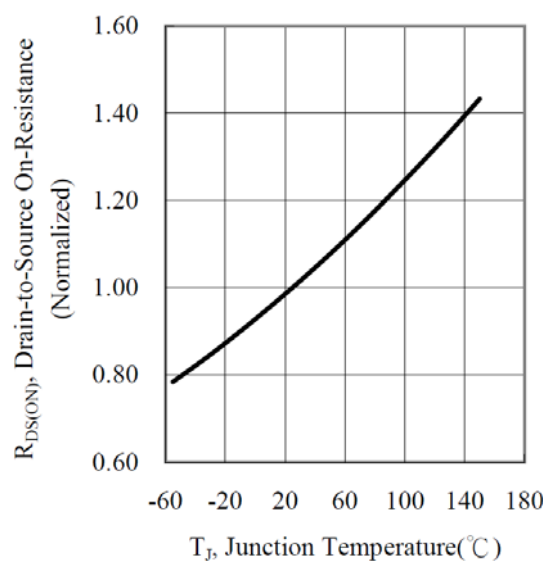


Figure 8: Drain-to-Source On-Resistance



PACKAGE MECHANICAL DATA

PDFN (5X6) Package Dimension (UNIT: mm)